







SN74HC14, SN54HC14

SCLS085K - DECEMBER 1982 - REVISED JUNE 2021

# **SNx4HC14 Hex Inverters with Schmitt-Trigger Inputs**

#### 1 Features

- **Buffered** inputs
- Wide operating voltage range: 2 V to 6 V
- Wide operating temperature range: -40°C to +85°C
- Supports fanout up to 10 LSTTL loads
- Significant power reduction compared to LSTTL logic ICs

# 2 Applications

- Synchronize invterted clock inputs
- Debounce a switch
- Invert a digital signal

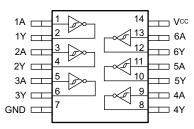
# 3 Description

This device contains six independent inverters with Schmitt-trigger inputs. Each gate performs the Boolean function  $Y = \overline{A}$  in positive logic.

#### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
SN74HC14DR	SOIC (14)	8.70 mm × 3.90 mm
SN74HC14DBR	SSOP (14)	6.40 mm × 5.30 mm
SN74HC14NR	PDIP (14)	19.30 mm × 6.40 mm
SN74HC14NSR	SO (14)	10.20 mm × 5.30 mm
SN74HC14PWR	TSSOP (14)	5.00 mm × 4.40 mm
SN54HC14JR	CDIP (14)	21.30 mm × 7.60 mm
SN54HC14WR	CFP (14)	9.20 mm × 6.29 mm
SN54HC14FKR	LCCC (20)	8.90 mm × 8.90 mm

For all available packages, see the orderable addendum at the end of the data sheet.



**Functional pinout** 



# **Table of Contents**

2 Applications	1	8.2 Functional Block Diagram	9
	1	8.3 Feature Description	
3 Description	1	8.4 Device Functional Modes	10
4 Revision History	<mark>2</mark>	9 Application and Implementation	11
5 Pin Configuration and Functions	3	9.1 Application Information	11
6 Specifications	4	9.2 Typical Application	11
6.1 Absolute Maximum Ratings	4	10 Power Supply Recommendations	13
6.2 ESD Ratings		11 Layout	
6.3 Recommended Operating Conditions		11.1 Layout Guidelines	
6.4 Thermal Information		11.2 Layout Example	
6.5 Electrical Characteristics - 74		12 Device and Documentation Support	
6.6 Electrical Characteristics - 54		12.1 Documentation Support	
6.7 Switching Characteristics - 74		12.2 Support Resources	
6.8 Switching Characteristics - 54		12.3 Trademarks	
6.9 Operating Characteristics		12.4 Electrostatic Discharge Caution	
6.10 Typical Characteristics		12.5 Glossary	14
7 Parameter Measurement Information		13 Mechanical, Packaging, and Orderable	
8 Detailed Description		Information	14
4 Revision History NOTE: Page numbers for previous revisions m Changes from Revision J (October 2016) to			Page
·		cross-references throughout the document	
	gui es anc		
<ul> <li>Undated to new data sheet standards</li> </ul>			
		-	1
<ul> <li>Updated package sizing for DB package in</li> </ul>	Device In	formation table	1
<ul> <li>Updated package sizing for DB package in</li> <li>Increased D (86 to 133.6), DB (96 to 114.8)</li> </ul>	 <i>Device In</i> ), NS (76 t	formation tableo 122.6), and PW (113 to 151.7); decreased i	1 1 N (80 to
<ul> <li>Updated package sizing for DB package in</li> <li>Increased D (86 to 133.6), DB (96 to 114.8)</li> </ul>	 <i>Device In</i> ), NS (76 t	formation table	1 1 N (80 to
<ul> <li>Updated package sizing for DB package in</li> <li>Increased D (86 to 133.6), DB (96 to 114.8) 60.7) °C/W</li> </ul>	Device In ), NS (76 t	formation table	1 N (80 to
<ul> <li>Updated package sizing for DB package in</li> <li>Increased D (86 to 133.6), DB (96 to 114.8 60.7) °C/W</li> <li>Changes from Revision I (February 2016) to</li> </ul>	Device In ), NS (76 t	formation tableo 122.6), and PW (113 to 151.7); decreased I	1 N (80 to4 Page
<ul> <li>Updated package sizing for DB package in</li> <li>Increased D (86 to 133.6), DB (96 to 114.8 60.7) °C/W</li> <li>Changes from Revision I (February 2016) to</li> <li>Changed " Y = A" to "Y = A" throughout</li> </ul>	Device In ), NS (76 t	formation tableo 122.6), and PW (113 to 151.7); decreased in J (October 2016)	1 N (80 to4  Page
<ul> <li>Updated package sizing for DB package in</li> <li>Increased D (86 to 133.6), DB (96 to 114.8 60.7) °C/W</li> <li>Changes from Revision I (February 2016) to</li> <li>Changed " Y = A" to "Y = A" throughout</li> <li>Added The SNx4HC14 to Description section</li> </ul>	Device In ), NS (76 t	formation tableo 122.6), and PW (113 to 151.7); decreased I	1 N (80 to4 Page1
<ul> <li>Updated package sizing for DB package in</li> <li>Increased D (86 to 133.6), DB (96 to 114.8 60.7) °C/W</li> <li>Changes from Revision I (February 2016) to</li> <li>Changed " Y = A" to "Y = A" throughout</li> <li>Added The SNx4HC14 to Description section.</li> <li>Deleted Device Comparison Table section.</li> </ul>	Device In ), NS (76 t	formation table	1 N (80 to4 Page11
<ul> <li>Updated package sizing for DB package in</li> <li>Increased D (86 to 133.6), DB (96 to 114.8 60.7) °C/W</li> <li>Changes from Revision I (February 2016) to</li> <li>Changed " Y = A" to "Y = A" throughout</li> <li>Added The SNx4HC14 to Description section.</li> <li>Deleted Device Comparison Table section.</li> </ul>	Device In ), NS (76 t	formation tableo 122.6), and PW (113 to 151.7); decreased I	1 N (80 to4 Page11
<ul> <li>Updated package sizing for DB package in</li> <li>Increased D (86 to 133.6), DB (96 to 114.8 60.7) °C/W</li> <li>Changes from Revision I (February 2016) to</li> <li>Changed " Y = A" to "Y = A" throughout</li> <li>Added The SNx4HC14 to Description section.</li> <li>Deleted Device Comparison Table section.</li> </ul>	Device In ), NS (76 t	formation table	1 N (80 to4 Page11
<ul> <li>Updated package sizing for DB package in</li> <li>Increased D (86 to 133.6), DB (96 to 114.8 60.7) °C/W</li> <li>Changes from Revision I (February 2016) to</li> <li>Changed " Y = A" to "Y = A" throughout</li> <li>Added The SNx4HC14 to Description section.</li> <li>Deleted Device Comparison Table section.</li> <li>Added Receiving Notification of Documents</li> <li>Changes from Revision H (September 2015)</li> </ul>	Device In ), NS (76 to  Revision on	formation table	1 N (80 to1  Page11111
<ul> <li>Updated package sizing for DB package in</li> <li>Increased D (86 to 133.6), DB (96 to 114.8 60.7) °C/W</li> <li>Changes from Revision I (February 2016) to</li> <li>Changed " Y = A" to "Y = A" throughout</li> <li>Added The SNx4HC14 to Description section.</li> <li>Deleted Device Comparison Table section.</li> <li>Added Receiving Notification of Documents</li> <li>Changes from Revision H (September 2015)</li> <li>Changed part number from SN54HC08 to State of the SN54HC08 to SN54HC08 to State of the SN54HC08 to SN54HC0</li></ul>	Device In ), NS (76 to  Revision  on	formation table	Page1 Page1 Page1 Page1
<ul> <li>Updated package sizing for DB package in</li> <li>Increased D (86 to 133.6), DB (96 to 114.8 60.7) °C/W</li> <li>Changes from Revision I (February 2016) to</li> <li>Changed " Y = A" to "Y = A" throughout</li> <li>Added The SNx4HC14 to Description section.</li> <li>Deleted Device Comparison Table section.</li> <li>Added Receiving Notification of Documents</li> <li>Changes from Revision H (September 2015)</li> <li>Changed part number from SN54HC08 to State of the SN54HC08 to SN54HC08 to State of the SN54HC08 to SN54HC0</li></ul>	Device In ), NS (76 to  Devision  Revision  On	formation table	Page1 Page1 Page1 Page1
<ul> <li>Updated package sizing for DB package in</li> <li>Increased D (86 to 133.6), DB (96 to 114.8 60.7) °C/W</li> <li>Changes from Revision I (February 2016) to</li> <li>Changed "Y = A" to "Y = A" throughout</li> <li>Added The SNx4HC14 to Description section.</li> <li>Deleted Device Comparison Table section.</li> <li>Added Receiving Notification of Documents</li> <li>Changes from Revision H (September 2015)</li> <li>Changed part number from SN54HC08 to Section.</li> <li>Changes from Revision G (January 2014) to</li> </ul>	Device In ), NS (76 to  Revision  on	formation table	Page Page Page Page Page Page Page Page
<ul> <li>Updated package sizing for DB package in</li> <li>Increased D (86 to 133.6), DB (96 to 114.8 60.7) °C/W</li> <li>Changes from Revision I (February 2016) to</li> <li>Changed "Y = A" to "Y = A" throughout</li> <li>Added The SNx4HC14 to Description section.</li> <li>Deleted Device Comparison Table section.</li> <li>Added Receiving Notification of Documenta</li> <li>Changes from Revision H (September 2015)</li> <li>Changed part number from SN54HC08 to Section.</li> <li>Changes from Revision G (January 2014) to</li> <li>Added Applications</li> </ul>	Device In ), NS (76 to  Revision  on	formation table	Page
<ul> <li>Updated package sizing for DB package in</li> <li>Increased D (86 to 133.6), DB (96 to 114.8 60.7) °C/W</li></ul>	Device In ), NS (76 to  Revision on	formation table	Page1 Page1 Page1 Page1 Page1 Page1
<ul> <li>Updated package sizing for DB package in</li> <li>Increased D (86 to 133.6), DB (96 to 114.8 60.7) °C/W.</li> <li>Changes from Revision I (February 2016) to</li> <li>Changed "Y = A" to "Y = A" throughout</li> <li>Added The SNx4HC14 to Description section.</li> <li>Deleted Device Comparison Table section.</li> <li>Added Receiving Notification of Documents</li> <li>Changes from Revision H (September 2015)</li> <li>Changed part number from SN54HC08 to Section.</li> <li>Changed part number from SN54HC08 to Section.</li> <li>Changes from Revision G (January 2014) to</li> <li>Added Applications</li> <li>Added Military Disclaimer to Features list</li> <li>Added Pin Configuration and Functions section.</li> </ul>	Device In ), NS (76 to  Prevision  The previous on the previous of the previou	formation table	Page1 Page1 Page1 Page1 Page1 Page1 Page1
<ul> <li>Updated package sizing for DB package in</li> <li>Increased D (86 to 133.6), DB (96 to 114.8 60.7) °C/W</li></ul>	Device In ), NS (76 to ), NS (76 to ), NS (76 to )  O Revision  ation Upda  SN54HC1  SN54HC1  O Revision  ction, ESD entation se	formation table	Page
<ul> <li>Updated package sizing for DB package in</li> <li>Increased D (86 to 133.6), DB (96 to 114.8 60.7) °C/W</li></ul>	Device In ), NS (76 to ), NS (76 to ), NS (76 to ) Revision  ation Upda  SN54HC1  SN54HC1  Contain Revision	formation table	Page

Page

Updated document to new TI data sheet format - no specification changes......1

Changes from Revision F (December 2010) to Revision G (January 2014)



# **5 Pin Configuration and Functions**

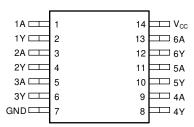


Figure 5-1. D, DB, N, NS, PW, J, or W Package 14-Pin SOIC, SSOP, PDIP, SO, TSSOP, CDIP, or CFP Top View

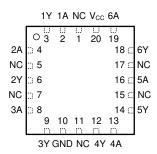


Figure 5-2. FK Package 20-Pin LCCC Top View

#### **Pin Functions**

	PIN			
NAME	D, DB, N, NS, PW, J, or W	FK	I/O	DESCRIPTION
1A	1	2	Input	Channel 1, Input A
1Y	2	3	Output	Channel 1, Output Y
2A	3	4	Input	Channel 2, Input A
2Y	4	6	Output	Channel 2, Output Y
3A	5	8	Input	Channel 3, Input A
3Y	6	9	Output	Channel 3, Output Y
GND	7	10	_	Ground
4Y	8	12	Output	Channel 4, Output Y
4A	9	13	Input	Channel 4, Input A
5Y	10	14	Output	Channel 5, Output Y
5A	11	16	Input	Channel 5, Input A
6Y	12	18	Output	Channel 6, Output Y
6A	13	19	Input	Channel 6, Input A
V <sub>CC</sub>	14	20	_	Positive Supply
NC		1, 5, 7, 11, 15, 17	_	Not internally connected



# **6 Specifications**

# **6.1 Absolute Maximum Ratings**

over operating free-air temperature range (unless otherwise noted)(1)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage		-0.5	7	V
I <sub>IK</sub>	Input clamp current <sup>(2)</sup>	$V_{I} < 0 \text{ or } V_{I} > V_{CC}$		±20	mA
I <sub>OK</sub>	Output clamp current <sup>(2)</sup>	V <sub>O</sub> < 0		±20	mA
Io	Continuous output current	$V_O = 0$ to $V_{CC}$		±25	mA
	Continuous current through V <sub>CC</sub> or GND			±50	mA
TJ	Junction temperature <sup>(3)</sup>			150	°C
T <sub>stg</sub>	Storage temperature		-60	150	°C

- (1) Stresses beyond those listed under Absolute Maximum Rating may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Condition. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
- (3) Guaranteed by design.

# 6.2 ESD Ratings

			VALUE	UNIT
V Flootroototia diagharga	Human-body model (HBM), per ANSI/ESDA/ JEDEC JS-001 <sup>(1)</sup>	±2000	\/	
V <sub>(ESD)</sub>	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	±1500	V

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

# **6.3 Recommended Operating Conditions**

over operating free-air temperature range (unless otherwise noted)

			MIN	NOM	MAX	UNIT	
V <sub>CC</sub>	Supply voltage	Supply voltage					
VI	Input voltage	nput voltage					
Vo	Output voltage		0		V <sub>CC</sub>	V	
_	Operating free air temperature	SN54HC04	-55		125	°C	
' A	Operating free-air temperature	SN74HC04	-40		85	C	

#### 6.4 Thermal Information

				SN74HC14			
	THERMAL METRIC <sup>(1)</sup>	D (SOIC)	D (SOIC) DB (SSOP) N (PD		NS (SO)	PW (TSSOP)	UNIT
		14 PINS	14 PINS	14 PINS	14 PINS	14 PINS	
R <sub>θJA</sub>	Junction-to-ambient thermal resistance	133.6	114.8	60.7	122.6	151.7	°C/W
R <sub>θ</sub> JC(top)	Junction-to-case (top) thermal resistance	89	64.5	47.8	81.8	79.4	°C/W
R <sub>θJB</sub>	Junction-to-board thermal resistance	89.5	65.1	40.6	83.8	94.7	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	45.5	23.7	26.9	45.4	25.2	°C/W
$\Psi_{JB}$	Junction-to-board characterization parameter	89.1	64.4	40.3	83.4	94.1	°C/W

Submit Document Feedback

Copyright © 2021 Texas Instruments Incorporated



THERMAL METRIC <sup>(1)</sup>							
		D (SOIC)	D (SOIC) DB (SSOP) N (PDIP) NS (SO) PW (TSSOP)				
		14 PINS	14 PINS	14 PINS	14 PINS	14 PINS	
R <sub>θ</sub> Junction-to-case (bottom) JC(bot) thermal resistance		N/A	N/A	N/A	N/A	N/A	°C/W

For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application

# 6.5 Electrical Characteristics - 74

over operating free-air temperature range; typical values measured at  $T_A$  = 25°C (unless otherwise noted).

					С	perating	free-air	temperat			
- 1	PARAMETER	TES	T CONDITIONS	V <sub>cc</sub>		25°C		-40°	C to 85°0	3	UNIT
					MIN	TYP	MAX	MIN	TYP	MAX	
	Positive			2 V	0.7	1.2	1.5	0.7		1.5	
$V_{T+}$	switching			4.5 V	1.55	2.5	3.13	1.55		3.13	V
	threshold			6 V	2.1	3.3	4.2	2.1		4.2	
	Negative			2 V	0.3	0.6	1	0.3		1	
$V_{T-}$	switching			4.5 V	0.9	1.6	2.45	0.9		2.45	V
	threshold			6 V	1.2	2	3.2	1.2		3.2	
				2 V	0.2	0.6	1.2	0.2		1.2	
$\Delta V_{T}$	Hysteresis (V <sub>T+</sub> - V <sub>T-</sub> )			4.5 V	0.4	0.9	2.1	0.4		2.1	V
	V 1-)			6 V	0.5	1.3	2.5	0.5		2.5	
				2 V	1.9	1.998		1.9			
			$I_{OH} = -20 \mu A$	4.5 V	4.4	4.499		4.4			
$V_{OH}$	High-level output voltage	$V_I = V_{IH}$ or $V_{II}$		6 V	5.9	5.999		5.9			V
	output voltage	OI VIL	I <sub>OH</sub> = -4 mA	4.5 V	3.98	4.3		3.84			
			I <sub>OH</sub> = -5.2 mA	6 V	5.48	5.8		5.34			
				2 V		0.002	0.1			0.1	
			I <sub>OL</sub> = 20 μA	4.5 V		0.001	0.1			0.1	
$V_{OL}$	Low-level output voltage	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub>		6 V		0.001	0.1			0.1	V
	Voltago	0. VIL	I <sub>OL</sub> = 4 mA	4.5 V		0.17	0.26			0.33	
			I <sub>OL</sub> = 5.2 mA	6 V		0.15	0.26			0.33	
l <sub>l</sub>	Input leakage current	V <sub>I</sub> = V <sub>CC</sub> o	or 0	6 V			±0.1			±1	μA
I <sub>CC</sub>	Supply current	V <sub>I</sub> = V <sub>CC</sub> or 0	I <sub>O</sub> = 0	6 V			2			20	μA
Ci	Input capacitance			5 V		3	10			10	pF

# 6.6 Electrical Characteristics - 54

over operating free-air temperature range; typical values measured at TA = 25°C (unless otherwise noted).

						Opera	ting free	-air temperatu	re (T <sub>A</sub> )	,	
	PARAMETER	TER TEST CONDITIONS			25°C		-40°	°C to 85°C	-55°	C to 125°C	UNIT
				MIN	TYP	MAX	MIN	TYP MAX	MIN	TYP MAX	
	V <sub>T+</sub> Positive switching threshold		2 V	0.7	1.2	1.5	0.7	1.5	0.7	1.5	
V <sub>T+</sub>			4.5 V	1.55	2.5	3.13	1.55	3.13	1.55	3.13	v
			6 V	2.1	3.3	4.2	2.1	4.2	2.1	4.2	



over operating free-air temperature range; typical values measured at TA = 25°C (unless otherwise noted).

							Opera	ting free	air temp	erature	e (T <sub>A</sub> )			
ı	PARAMETER	TEST CO	NDITIONS	Vcc		25°C		-40°	°C to 85°C	C	-55°C	C to 125	°C	UNIT
					MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
	Negative			2 V	0.3	0.6	1	0.3		1	0.3		1	
V <sub>T-</sub>	switching			4.5 V	0.9	1.6	2.45	0.9		2.45	0.9		2.45	V
	threshold			6 V	1.2	2	3.2	1.2		3.2	1.2		3.2	
				2 V	0.2	0.6	1.2	0.2		1.2	0.2		1.2	
$\Delta V_T$	Hysteresis (V <sub>T+</sub> - V <sub>T-</sub> )			4.5 V	0.4	0.9	2.1	0.4		2.1	0.4		2.1	V
	V 1-/			6 V	0.5	1.3	2.5	0.5		2.5	0.5		2.5	
				2 V	1.9	1.998		1.9			1.9			
			I <sub>OH</sub> = -20 μΑ	4.5 V	4.4	4.499		4.4			4.4			
	High-level	V <sub>I</sub> = V <sub>IH</sub> or	μ, ,	6 V	5.9	5.999		5.9			5.9			
V <sub>OH</sub>	output voltage	V <sub>IL</sub>	I <sub>OH</sub> = -4 mA	4.5 V	3.98	4.3		3.84			3.7			V
			I <sub>OH</sub> = -5.2 mA	6 V	5.48	5.8		5.34			5.2			
				2 V		0.002	0.1			0.1			0.1	
			I <sub>OL</sub> = 20 μΑ	4.5 V		0.001	0.1			0.1			0.1	
V <sub>OL</sub>	Low-level output	$V_I = V_{IH}$ or	μ, τ	6 V		0.001	0.1			0.1			0.1	V
- OL	voltage	V <sub>IL</sub>	I <sub>OL</sub> = 4 mA	4.5 V		0.17	0.26			0.33			0.33	·
			I <sub>OL</sub> = 5.2 mA	6 V		0.15	0.26			0.33			0.33	
I	Input leakage current	V <sub>I</sub> = V <sub>CC</sub> or		6 V			±0.1			±1			±1	μΑ
I <sub>CC</sub>	Supply current	$V_I = V_{CC}$ or 0	I <sub>O</sub> = 0	6 V			2			20			40	μΑ
Ci	Input capacitance		1	2 V to 6 V		3	10			10			10	pF

# 6.7 Switching Characteristics - 74

over operating free-air temperature range (unless otherwise noted)

	PARAMETER		Operating free-air tempe						perature (T <sub>A</sub> )		
			FROM TO V <sub>CC</sub>			25°C		–40°	C to 85°	,C	UNIT
					MIN	TYP	MAX	MIN	TYP	MAX	
				2 V		55	125			155	
t <sub>pd</sub>	Propagation delay	Α	Y	4.5 V		12	25			31	ns
				6 V		11	21			26	
				2 V		38	75			95	
t <sub>t</sub>	Transition-time		Υ	4.5 V		8	15			19	ns
				6 V		6	13			16	



# 6.8 Switching Characteristics - 54

over operating free-air temperature range; typical values measured at TA = 25°C (unless otherwise noted).

					Operating free-air temperature (T <sub>A</sub> )										
PARAMETER		FROM	то	V <sub>cc</sub>	25°C			-40°C to 85°C			-55°C	C to 12	5°C	UNIT	
					MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX		
			2 V		55	125			155			190			
t <sub>pd</sub>	Propagation delay	Α	Υ	4.5 V		12	25			31			38	ns	
				6 V		11	21			26			22		
	t <sub>t</sub> Transition-time		Y	2 V		38	75			95		110			
t <sub>t</sub> T				4.5 V		8	15			19			22	ns	
				6 V		6	13			16			19		

# **6.9 Operating Characteristics**

over operating free-air temperature range; typical values measured at  $T_A$  = 25°C (unless otherwise noted).

	PARAMETER	TEST CONDITIONS	V <sub>cc</sub>	MIN	TYP	MAX	UNIT
Cnd	Power dissipation capacitance per gate	No load	2 V to 6 V	,	20		pF

# **6.10 Typical Characteristics**

T<sub>A</sub> = 25°C

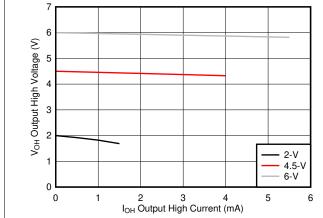


Figure 6-1. Typical output voltage in the high state  $(V_{OH})$ 

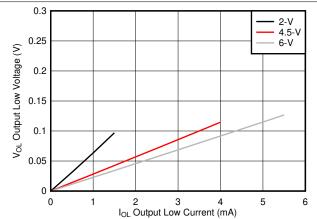
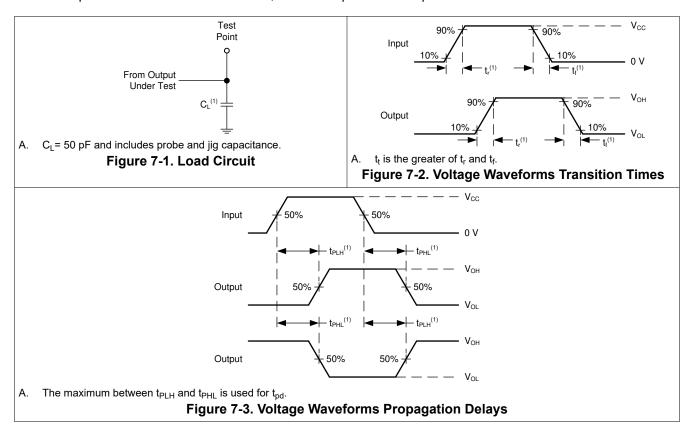


Figure 6-2. Typical output voltage in the low state  $(V_{OL})$ 



# 7 Parameter Measurement Information

- Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz,  $Z_O = 50 \Omega$ ,  $t_t < 6$  ns.
- The outputs are measured one at a time, with one input transition per measurement.

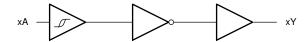


# 8 Detailed Description

#### 8.1 Overview

This device contains six independent inverters with Schmitt-trigger inputs. Each gate performs the Boolean function  $Y = \overline{A}$  in positive logic.

## 8.2 Functional Block Diagram



#### 8.3 Feature Description

#### 8.3.1 Balanced CMOS Push-Pull Outputs

A balanced output allows the device to sink and source similar currents. The drive capability of this device may create fast edges into light loads so routing and load conditions should be considered to prevent ringing. Additionally, the outputs of this device are capable of driving larger currents than the device can sustain without being damaged. It is important for the output power of the device to be limited to avoid damage due to over-current. The electrical and thermal limits defined in the *Absolute Maximum Ratings* must be followed at all times.

The SN74HC14 can drive a load with a total capacitance less than or equal to the maximum load listed in the *Switching Characteristics* - 74 connected to a high-impedance CMOS input while still meeting all of the datasheet specifications. Larger capacitive loads can be applied, however it is not recommended to exceed the provided load value. If larger capacitive loads are required, it is recommended to add a series resistor between the output and the capacitor to limit output current to the values given in the *Absolute Maximum Ratings*.

## 8.3.2 CMOS Schmitt-Trigger Inputs

Standard CMOS inputs are high impedance and are typically modeled as a resistor from the input to ground in parallel with the input capacitance given in the *Electrical Characteristics - 74*. The worst case resistance is calculated with the maximum input voltage, given in the *Absolute Maximum Ratings*, and the maximum input leakage current, given in the *Electrical Characteristics - 74*, using ohm's law  $(R = V \div I)$ .

The Schmitt-trigger input architecture provides hysteresis as defined by  $\Delta V_T$  in the *Electrical Cahracteristics* - 74, which makes this device extremely tolerant to slow or noisy inputs. While the inputs can be driven much slower than standard CMOS inputs, it is still recommended to properly terminate unused inputs. Driving the inputs slowly will also increase dynamic current consumption of the device. For additional information regarding Schmitt-trigger inputs, please see Understanding Schmitt Triggers.



# 8.3.3 Clamp Diode Structure

The inputs and outputs to this device have both positive and negative clamping diodes as depicted in Figure 8-1.

#### **CAUTION**

Voltages beyond the values specified in the Absolute Maximum Ratings table can cause damage to the device. The recommended input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

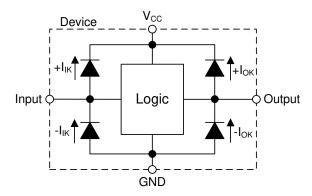


Figure 8-1. Electrical Placement of Clamping Diodes for Each Input and Output

# **8.4 Device Functional Modes**

**Table 8-1. Function Table** 

INPUT	OUTPUT
Α	Υ
L	Н
Н	L

# 9 Application and Implementation

#### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

#### 9.1 Application Information

This device can be used to add an additional stage to a counter with an external flip-flop. Because counters use a negative edge trigger, the flip-flop's clock input must be inverted to provide this function. This function only requires one of the six available inverters in the device, so the remaining channels can be used for other applications needing an inverted signal or improved signal integrity. Unused inputs must be terminated at  $V_{CC}$  or GND. Unused outputs can be left floating.

## 9.2 Typical Application

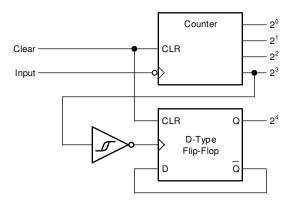


Figure 9-1. Typical application schematic

#### 9.2.1 Design Requirements

#### 9.2.1.1 Power Considerations

Ensure the desired supply voltage is within the range specified in the *Recommended Operating Conditions*. The supply voltage sets the device's electrical characteristics as described in the *Electrical Characteristics - 74*.

The supply must be capable of sourcing current equal to the total current to be sourced by all outputs of the SN74HC14 plus the maximum supply current,  $I_{CC}$ , listed in the *Electrical Characteristics - 74*. The logic device can only source or sink as much current as it is provided at the supply and ground pins, respectively. Be sure not to exceed the maximum total current through GND or  $V_{CC}$  listed in the *Absolute Maximum Ratings*.

Total power consumption can be calculated using the information provided in CMOS Power Consumption and  $C_{\text{pd}}$  Calculation.

Thermal increase can be calculated using the information provided in Thermal Characteristics of Standard Linear and Logic (SLL) Packages and Devices.

#### CAUTION

The maximum junction temperature,  $T_J(max)$  listed in the *Absolute Maximum Ratings*, is an *additional limitation* to prevent damage to the device. Do not violate any values listed in the *Absolute Maximum Ratings*. These limits are provided to prevent damage to the device.

#### 9.2.1.2 Input Considerations

Input signals must cross  $V_{t-}(min)$  to be considered a logic LOW, and  $V_{t+}(max)$  to be considered a logic HIGH. Do not exceed the maximum input voltage range found in the *Absolute Maximum Ratings*.

Unused inputs must be terminated to either  $V_{CC}$  or ground. These can be directly terminated if the input is completely unused, or they can be connected with a pull-up or pull-down resistor if the input is to be used sometimes, but not always. A pull-up resistor is used for a default state of HIGH, and a pull-down resistor is used for a default state of LOW. The resistor size is limited by drive current of the controller, leakage current into the SN74HC14, as specified in the *Electrical Characteristics - 74*, and the desired input transition rate. A 10-k $\Omega$  resistor value is often used due to these factors.

The SN74HC14 has no input signal transition rate requirements because it has Schmitt-trigger inputs.

Another benefit to having Schmitt-trigger inputs is the ability to reject noise. Noise with a large enough amplitude can still cause issues. To know how much noise is too much, please refer to the  $\Delta V_T$ (min) in the *Electrical Characteristics - 74*. This hysteresis value will provide the peak-to-peak limit.

Unlike what happens with standard CMOS inputs, Schmitt-trigger inputs can be held at any valid value without causing huge increases in power consumption. The typical additional current caused by holding an input at a value other than V<sub>CC</sub> or ground is plotted in the *Typical Characteristics*.

Refer to the *Feature Description* for additional information regarding the inputs for this device.

#### 9.2.1.3 Output Considerations

The positive supply voltage is used to produce the output HIGH voltage. Drawing current from the output will decrease the output voltage as specified by the  $V_{OH}$  specification in the *Electrical Characteristics - 74*. Similarly, the ground voltage is used to produce the output LOW voltage. Sinking current into the output will increase the output voltage as specified by the  $V_{OL}$  specification in the *Electrical Characteristics 74*.

Unused outputs can be left floating. Do not connect outputs directly to V<sub>CC</sub> or ground.

Refer to Feature Description for additional information regarding the outputs for this device.

#### 9.2.2 Detailed Design Procedure

- 1. Add a decoupling capacitor from V<sub>CC</sub> to GND. The capacitor needs to be placed physically close to the device and electrically close to both the V<sub>CC</sub> and GND pins. An example layout is shown in the *Layout*.
- Ensure the capacitive load at the output is ≤ 70 pF. This is not a hard limit, however it will ensure optimal
  performance. This can be accomplished by providing short, appropriately sized traces from the SN74HC14
  to the receiving device.
- 3. Ensure the resistive load at the output is larger than  $(V_{CC} / I_O(max)) \Omega$ . This will ensure that the maximum output current from the *Absolute Maximum Ratings* is not violated. Most CMOS inputs have a resistive load measured in megaohms; much larger than the minimum calculated above.
- 4. Thermal issues are rarely a concern for logic gates, however the power consumption and thermal increase can be calculated using the steps provided in the application report, CMOS Power Consumption and Cpd Calculation

#### 9.2.3 Application Curves

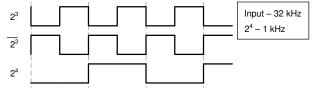


Figure 9-2. Typical application timing diagram

# 10 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions*. Each  $V_{CC}$  terminal should have a bypass capacitor to prevent power disturbance. A 0.1- $\mu$ F capacitor is recommended for this device. It is acceptable to parallel multiple bypass caps to reject different frequencies of noise. The 0.1- $\mu$ F and 1- $\mu$ F capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results, as shown in *Figure 11-1*.

## 11 Layout

## 11.1 Layout Guidelines

When using multiple-input and multiple-channel logic devices inputs must not ever be left floating. In many cases, functions or parts of functions of digital logic devices are unused; for example, when only two inputs of a triple-input AND gate are used. Such unused input pins must not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. All unused inputs of digital logic devices must be connected to a logic high or logic low voltage, as defined by the input voltage specifications, to prevent them from floating. The logic level that must be applied to any particular unused input depends on the function of the device. Generally, the inputs are tied to GND or  $V_{CC}$ , whichever makes more sense for the logic function or is more convenient.

## 11.2 Layout Example

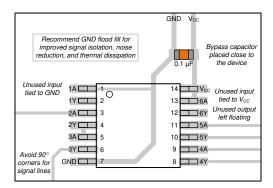


Figure 11-1. Example layout for the SN74HC14



# 12 Device and Documentation Support

## **12.1 Documentation Support**

#### 12.1.1 Related Documentation

For related documentation see the following:

- HCMOS Design Considerations
- CMOS Power Consumption and CPD Calculation
- · Designing with Logic

### 12.2 Support Resources

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

#### 12.3 Trademarks

TI E2E™ is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

## 12.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

## 12.5 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

### 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

www.ti.com 19-Nov-2024

# **PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Sample
5962-8409101VCA	ACTIVE	CDIP	J	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8409101VC A SNV54HC14J	Samples
5962-8409101VDA	ACTIVE	CFP	W	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8409101VD A SNV54HC14W	Samples
84091012A	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	84091012A SNJ54HC 14FK	Samples
8409101CA	ACTIVE	CDIP	J	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	8409101CA SNJ54HC14J	Samples
8409101DA	ACTIVE	CFP	W	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	8409101DA SNJ54HC14W	Samples
JM38510/65702BCA	ACTIVE	CDIP	J	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	JM38510/ 65702BCA	Samples
JM38510/65702BDA	ACTIVE	CFP	W	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	JM38510/ 65702BDA	Samples
M38510/65702BCA	ACTIVE	CDIP	J	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	JM38510/ 65702BCA	Samples
M38510/65702BDA	ACTIVE	CFP	W	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	JM38510/ 65702BDA	Samples
SN54HC14J	ACTIVE	CDIP	J	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	SN54HC14J	Samples
SN74HC14D	OBSOLETE	SOIC	D	14		TBD	Call TI	Call TI	-40 to 85	HC14	
SN74HC14DBR	ACTIVE	SSOP	DB	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC14	Sample
SN74HC14DR	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU   SN	Level-1-260C-UNLIM	-40 to 85	HC14	Sample
SN74HC14DRG3	ACTIVE	SOIC	D	14	2500	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 85	HC14	Sample
SN74HC14DRG4	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC14	Sample
SN74HC14DT	OBSOLETE	SOIC	D	14		TBD	Call TI	Call TI	-40 to 85	HC14	
SN74HC14N	ACTIVE	PDIP	N	14	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-40 to 85	SN74HC14N	Sample



www.ti.com 19-Nov-2024

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
SN74HC14NE4	ACTIVE	PDIP	N	14	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-40 to 85	SN74HC14N	Samples
SN74HC14NSR	ACTIVE	SO	NS	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC14	Samples
SN74HC14NSRE4	ACTIVE	SO	NS	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC14	Samples
SN74HC14PW	OBSOLETE	TSSOP	PW	14		TBD	Call TI	Call TI	-40 to 85	HC14	
SN74HC14PWR	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU   SN	Level-1-260C-UNLIM	-40 to 85	HC14	Samples
SN74HC14PWRG4	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC14	Samples
SN74HC14PWT	OBSOLETE	TSSOP	PW	14		TBD	Call TI	Call TI	-40 to 85	HC14	
SNJ54HC14FK	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	84091012A SNJ54HC 14FK	Samples
SNJ54HC14J	ACTIVE	CDIP	J	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	8409101CA SNJ54HC14J	Samples
SNJ54HC14W	ACTIVE	CFP	W	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	8409101DA SNJ54HC14W	Samples

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

# PACKAGE OPTION ADDENDUM

www.ti.com 19-Nov-2024

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

#### OTHER QUALIFIED VERSIONS OF SN54HC14, SN54HC14-SP, SN74HC14:

Catalog: SN74HC14, SN54HC14

Automotive: SN74HC14-Q1, SN74HC14-Q1

Military: SN54HC14

Space : SN54HC14-SP

#### NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Automotive Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Military QML certified for Military and Defense Applications
- Space Radiation tolerant, ceramic packaging and qualified for use in Space-based application



www.ti.com 27-Oct-2024

# TAPE AND REEL INFORMATION



# TAPE DIMENSIONS + K0 - P1 - B0 W Cavity - A0 -

A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74HC14DBR	SSOP	DB	14	2000	330.0	16.4	8.35	6.6	2.4	12.0	16.0	Q1
SN74HC14DR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74HC14DRG3	SOIC	D	14	2500	330.0	16.4	6.6	9.3	2.1	8.0	16.0	Q1
SN74HC14DRG4	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74HC14NSR	so	NS	14	2000	330.0	16.4	8.45	10.55	2.5	12.0	16.2	Q1
SN74HC14NSR	so	NS	14	2000	330.0	16.4	8.45	10.55	2.5	12.0	16.2	Q1
SN74HC14PWRG4	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1



www.ti.com 27-Oct-2024



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74HC14DBR	SSOP	DB	14	2000	356.0	356.0	35.0
SN74HC14DR	SOIC	D	14	2500	367.0	367.0	38.0
SN74HC14DRG3	SOIC	D	14	2500	366.0	364.0	50.0
SN74HC14DRG4	SOIC	D	14	2500	356.0	356.0	35.0
SN74HC14NSR	SO	NS	14	2000	356.0	356.0	35.0
SN74HC14NSR	SO	NS	14	2000	367.0	367.0	38.0
SN74HC14PWRG4	TSSOP	PW	14	2000	356.0	356.0	35.0



www.ti.com 27-Oct-2024

# **TUBE**



\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
5962-8409101VDA	W	CFP	14	25	506.98	26.16	6220	NA
84091012A	FK	LCCC	20	55	506.98	12.06	2030	NA
8409101DA	W	CFP	14	25	506.98	26.16	6220	NA
JM38510/65702BDA	W	CFP	14	25	506.98	26.16	6220	NA
M38510/65702BDA	W	CFP	14	25	506.98	26.16	6220	NA
SN74HC14N	N	PDIP	14	25	506	13.97	11230	4.32
SN74HC14N	N	PDIP	14	25	506	13.97	11230	4.32
SN74HC14NE4	N	PDIP	14	25	506	13.97	11230	4.32
SN74HC14NE4	N	PDIP	14	25	506	13.97	11230	4.32
SNJ54HC14FK	FK	LCCC	20	55	506.98	12.06	2030	NA
SNJ54HC14W	W	CFP	14	25	506.98	26.16	6220	NA



SMALL OUTLINE INTEGRATED CIRCUIT



- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm, per side.
- 5. Reference JEDEC registration MS-012, variation AB.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



# **MECHANICAL DATA**

# NS (R-PDSO-G\*\*)

# 14-PINS SHOWN

# PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



# W (R-GDFP-F14)

# CERAMIC DUAL FLATPACK



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only.
- E. Falls within MIL STD 1835 GDFP1-F14







- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
  4. Reference JEDEC registration MO-150.





NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



8.89 x 8.89, 1.27 mm pitch

LEADLESS CERAMIC CHIP CARRIER

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



CERAMIC DUAL IN LINE PACKAGE



Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.

4040083-5/G





CERAMIC DUAL IN LINE PACKAGE



- 1. All controlling linear dimensions are in inches. Dimensions in brackets are in millimeters. Any dimension in brackets or parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This package is hermitically sealed with a ceramic lid using glass frit.
- His package is remitted by sealed with a ceramic its using glass mit.
   Index point is provided on cap for terminal identification only and on press ceramic glass frit seal only.
   Falls within MIL-STD-1835 and GDIP1-T14.



CERAMIC DUAL IN LINE PACKAGE



# N (R-PDIP-T\*\*)

# PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.







- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.





NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



# IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2024, Texas Instruments Incorporated